Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/700,216	SCHANTZ, JOHN L.	
Examiner	Art Unit	

2614

Benny Q. Tieu

SEARCHED					
SEARCHED					
Class	Subclass	Date	Examiner		
379	229 230 221.08- 221.1	10/28/2006	вот		
370	401 410 467				
			-		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
See Interfere	ext Search, ence Search itout	4/15/2007	вот	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	10/28/2006	BQT	
Interference Search History Printout	4/15/2007	BQT	
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